

Notice of References Cited	Application/Control No. 10/525,270		Applicant(s)/Patent Under Reexamination SUNDSTROM, HENRIK	
	Examiner HANH T. BUI		Art Unit 2192	Page 1 of 1

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*	B	US-7,380,093	05-2008	Shimazaki et al.	711/171
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NON-PATENT DOCUMENTS

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